SGS

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RF Exposure Evaluation Report

Test Result :	PASS*		
Date of Issue:	2016-01-12		
Date of Test:	2015-11-25 to 2016-01-06		
Date of Receipt:	2015-11-23		
Standards:	47 CFR Part 1.1307 (2014) 47 CFR Part 1.1310 (2014) KDB447498D01 General RF Exposure Guidance v06		
FCC ID:	Z4TXADOW-GSMBTV10		
Trade Mark:	Seeedstudio		
Add Model No.:	Xadow GSM + BLE v1.1		
Model No.(EUT):	Xadow GSM + BLE v1.0		
Product Name:	Rephone Kit Create (Xadow GSM + BLE)		
Manufacturer/Factory:	Seeed Technology Co., Ltd		
Applicant:	Seeed Technology Co., Ltd		
Application No.:	SZEM1510006644CR		

* In the configuration tested, the EUT complied with the standards specified above.

Authorized Signature:



EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the federal government. All test results in this report can be traceable to National or International Standards.



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2 Version

Revision Record								
Version	Version Chapter Date Modifier Remark							
00		2016-01-12		Original				

Authorized for issue by:		
	Gebin Sun	2016-01-06
Tested By	(Gebin Sun) /Project Engineer	Date
	Jorde Chen	2016-01-12
Prepared By	(Jade Chen) /Clerk	Date
	Eric Fu	2016-01-12
Checked By	(Eric Fu) /Reviewer	Date

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4 General Information

4.1 Client Information

Applicant:	Seeed Technology Co., Ltd		
Address of Applicant:	F5, Building 8, Shiling Industrial Park, Xinwei, Number32, Tongsha Road Xili Town, Nanshan District, Shenzhen, China. P.R.C		
Manufacturer: Seeed Technology Co., Ltd			
Address of Manufacturer:	F5, Building 8, Shiling Industrial Park, Xinwei, Number32, Tongsha Road Xili Town, Nanshan District, Shenzhen, China. P.R.C		
Factory: Seeed Technology Co., Ltd			
Address of Factory:	F5, Building 8, Shiling Industrial Park, Xinwei, Number32, Tongsha Road Xili Town, Nanshan District, Shenzhen, China. P.R.C		

4.2 General Description of EUT

Product Name:	Rephone Kit Create (Xadow GSM + BLE)		
Model No.:	Xadow GSM + BLE v1.0		
Trade Mark:	Seeedstudio		
Bluetooth Version:	BT4.0 Dual mode		
Sample Type:	Mobile device		
Antenna Type:	Integral		
Antenna Gain:	0.5dBi		
Power Supply:	DC3.7V (1 x 3.7V Rechargeable battery) 520mAh		
	Battery: Charge by DC 5V		
For Classic Mode			
Modulation Technique:	Frequency Hopping Spread Spectrum(FHSS)		
Modulation Type:	GFSK, π/4DQPSK, 8DPSK		
Number of Channel:	79		
Hopping Channel Type:	Adaptive Frequency Hopping systems		
For BLE Mode			
Operation Frequency:	2402MHz~2480MHz		
Bluetooth Version:	BT4.0 Dual mode		
Modulation Type:	GFSK		
Number of Channel:	40		



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For GSM	For GSM						
Support Frequency Range:	Support Frequency Range: GSM850 Transmission (TX): 824 to 849 MHz						
		Receiving (RX): 869 to 894 MHz					
	GSM1900	Transmission (TX): 1850 to 1910 MHz					
		Receiving (RX): 1930 to 1990 MHz					

Remark:

Model No.: Xadow GSM + BLE v1.0, Xadow GSM + BLE v1.1

Only the model Xadow GSM + BLE v1.0 was tested, since the electrical circuit design, layout, components used and internal wiring were identical for the above models, with difference being of sick-screen.

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4.3 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch E&E Lab

No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China 518057

Telephone: +86 (0) 755 2601 2053 Fax: +86 (0) 755 2671 0594

No tests were sub-contracted.

4.4 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

• A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

VCCI

The 10m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-823, R-4188, T-1153 and C-2383 respectively.

FCC – Registration No.: 556682

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No.: 556682.

Industry Canada (IC)

The 3m Semi-anechoic chambers and the 10m Semi-anechoic chambers of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-2, 4620C-3.

4.5 Deviation from Standards

None.

4.6 Abnormalities from Standard Conditions

None.

4.7 Other Information Requested by the Customer

None.

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5 **RF Exposure Evaluation**

5.1 RF Exposure Compliance Requirement

5.1.1 Limits

According to FCC Part1.1310: The criteria listed in the following table shall be used to evaluate the environment impact of human exposure to radio frequency (RF) radiation as specified in part1.1307(b) TABLE 1—LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm ²)	Averaging time (minutes)					
(A) Lim	(A) Limits for Occupational/Controlled Exposures								
0.3–3.0 3.0–30 30–300 300–1500 1500–100,000	614 1842/f 61.4	1.63 4.89/f 0.163	*(100) *(900/f2) 1.0 f/300 5	6 6 6 6					
(B) Limits	for General Populati	ion/Uncontrolled Exp	oosure						
0.3–1.34 1.34–30 30–300 300–1500 1500–100,000	614 824/f 27.5	1.63 2.19/f 0.073	*(100) *(180/f ²) 0.2 f/1500 1.0	30 30 30 30 30					

F= Frequency in MHz

Friis Formula

Friis transmission formula: $Pd = (Pout^{*}G)/(4^{*}Pi^{*}R^{2})$

Where

Pd = power density in mW/cm2

Pout = output power to antenna in mW

G = gain of antenna in linear scale

Pi = 3.1416

R = distance between observation point and center of the radiator in cm

Pd id the limit of MPE, 1 mW/cm2. If we know the maximum gain of the antenna and the total power input to the antenna, through the calculation, we will know the distance r where the MPE limit is reached.

5.1.2 Test Procedure

Software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel individually.



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5.1.3 EUT RF Exposure Evaluation

1) . exposure conditions for standalone operations

Antenna Gain: 0.5dBi

Antenna Gain: The maximum Gain measured in fully anechoic chamber is 1.12 in linear scale. Output Power Into Antenna & RF Exposure Evaluation Distance:

For Classic Mode

Channel	Frequency (MHz)	Max ConductedOutput PowerPeak Outputto Antenna		Power Density at R = 20 cm	Limit	MPE Ratios	Result
		Power (dBm)	(mW)	(mW/cm²)			
Middle	2441	5.45	3.51	0.0003	1.0	0.0003	PASS

Note: Refer to report No. SZEM151000664403 for EUT test Max Conducted Peak Output Power value. The distancer (4th column) calculated from the Fries transmission formula is far greater than 20 cm separation

For BLE Mode

Channel	Frequency	Max Conducted	Output Power	Power Density	Limit	MPE	Result
	(MHz)	Peak Output	to Antenna	at R = 20 cm		Ratios	
		Power (dBm)	(mW)	(mW/cm ²)			
Lowest	2402	5.39	3.46	0.0003	1.0	0.0003	PASS

Note: Refer to report No. SZEM151000664402 for EUT test Max Conducted Peak Output Power value. The distancer (4th column) calculated from the Fries transmission formula is far greater than 20 cm separation



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For GSM

GSM 850								
Burst Output Power(dBm) Division Factors Frame-Average Output Power(dBm)								
GSM(C	GSM(CS) 33.41			24.22				
	1 TX Slot	33.40	-9.19	24.21				
GPRS	2 TX Slots	32.15	-6.18	25.97				
(GMSK)	3 TX Slots	31.08	-4.42	26.66				
	4 TX Slots	30.23	-3.17	27.06				

GSM 1900								
Bu	rst Output Power	(dBm)	Division Factors	Frame-Average Output Power(dBm)				
GSM(CS) 31.02			-9.19	21.83				
	1 TX Slot	30.98	-9.19	21.79				
GPRS	2 TX Slots	29.85	-6.18	23.67				
(GMSK)	3 TX Slots	28.71	-4.42	24.29				
	4 TX Slots	27.72	-3.17	24.55				

Frequency band	Test ch./Freq.	Max Conducted Output Power (dBm)	Output Power to Antenna (mW)	Power Density at R = 20 cm (mW/cm2)	Limit	MPE Ratios	Result
GSM850	251/848.8	27.06	E08 4E0	0.0505	0.57	0.089	PASS
(GPRS)	231/040.0	27.00	508.159	0.0305	0.57	0.089	F A33
GSM1900	004/4000.0		005 400	0.0004	1.0	0.000	
(GPRS)	661/1880.0	24.55	285.102	0.0284	1.0	0.028	PASS

Note: Refer to Appendix B of Test Report SZEM151000664404 for EUT test Max Conducted Peak Output Power value.

The distance r (4th column) calculated from the Fries transmission formula is far greater than 20 cm separation requirement.

2). exposure conditions for simultaneous transmission operations

Simultaneous transmission MPE test is not required, because the Max. sum of the MPE ratios for GSM and BT is 0.089+0.0003=0.0893<1